

**Search Notes**

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Examiner

Leon J. Harper

Applicant(s)/Patent under  
Reexamination

KAWAI ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
707	200,104.1, 1,10,8,6,5, 4	3/2/2006	LJH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR